

Application No.	Applicant(s)
10/677,936	WALZ, DONALD L.
Examiner	Art Unit
Tan Dean D. Nouven	3629

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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	SEARCH NOT (INCLUDING SEARCH)
		DATE	EXMR
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I	US: 1) Patent 2) PG Pub	3/10/05	ær,
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I	FOREGIN:		
	1) = PO 2) JPO 3) Derwent		
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2) US FOR

3 NPL

SEARCH NOTES

Serial No. <u>10</u> PCT US	1677,	936	
1. <u>US</u> Classified Search:	<u>2</u>	<u>3</u>	. <u>4</u>
2. <u>US:</u>			
1) US Patent 2) US PG Pub			
3. <u>FOREIGN:</u>			
1) Derwent 2) EPO 3) JPO 4)			
4. NPL: Dialog OneSearch			
1) Ftext1, Ftext2 2) NFtext 3) 4) 5)			